

MOSFET - Power, Single N-Channel

100 V, 38 mΩ, 21 A

NVTFS040N10MCL

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFWS040N10MCL Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	100	V
Gate-to-Source Voltage	€		V _{GS}	±20	٧
Continuous Drain		T _C = 25°C	I _D	21	Α
Current R _{0JC} (Notes 1, 2, 3)	Steady	T _C = 100°C		15	
Power Dissipation	State	T _C = 25°C	P _D	36	W
R _{θJC} (Notes 1, 2)		T _C = 100°C		18	
Continuous Drain		T _A = 25°C	I _D	6.1	Α
Current R _{0JA} (Notes 1, 2, 3)	Steady	T _A = 100°C		4.3	
Power Dissipation	State	T _A = 25°C	P _D	3.1	W
R _{θJA} (Notes 1, 2)		T _A = 100°C		1.5	
Pulsed Drain Current	T _C = 25	°C, t _p = 10 μs	I _{DM}	82	Α
Source Current (Body D	iode)		Is	28	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 0.9 A)			E _{AS}	109	mJ
Lead Temperature for S (1/8" from case for 10 s)		urposes	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

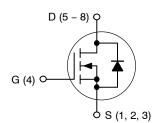
THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{\theta JC}$	4.2	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	49	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
100 V	38 m Ω @ 10 V	21 A	
	53 mΩ @ 4.5 V	217	

N-Channel





WDFN8 (μ8FL) CASE 511AB



WDFNW8 (μ8FL WF) CASE 515AN







XXXXX = Specific Device Code
A = Assembly Location

Y = Year WW = Work Week ■ = Pb-Free Package

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Conditi	on	Min	Тур	Max	Unit
OFF CHARACTERISTICS						ı	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 2	250 μΑ	100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				50.3		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	μΑ
		V _{DS} = 100 V	T _J = 125°C			100	1
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} :	= 20 V			100	nA
ON CHARACTERISTICS (Note 4)							•
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	26 μΑ	1.0		3.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.7		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 5 A		31	38	mΩ
		V _{GS} = 4.5 V	I _D = 4 A		42	53	1
Forward Transconductance	9FS	V _{DS} = 10 V, I _D	= 5 A		18		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE					1	
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz,	V _{DS} = 50 V		520		pF
Output Capacitance	C _{OSS}				200		
Reverse Transfer Capacitance	C _{RSS}				3.2		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 50	0 V; I _D = 4 A		4.1		nC
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 50) V; I _D = 5 A		8.6		1
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _{DS} = 50) V; I _D = 5 A		0.7		nC
Gate-to-Source Charge	Q _{GS}				1.7		1
Gate-to-Drain Charge	Q_{GD}				1.3		1
Plateau Voltage	V_{GP}				2.9		V
SWITCHING CHARACTERISTICS (Note 5	5)						•
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 10 \text{ V}, V_{DS}$	= 50 V,		7.0		ns
Rise Time	t _r	I _D = 5 A			7.4		1
Turn-Off Delay Time	t _{d(OFF)}				16.3		
Fall Time	t _f				3.8		
DRAIN-SOURCE DIODE CHARACTERIS	TICS					1	
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V}, I_{S} = 5 \text{ A},$	T _J = 25°C		0.85	1.3	V
		V _{GS} = 0 V, I _S = 5 A,	Γ _J = 125°C		0.73		1
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V}, dI_{S}/dt = 100$	A/μs, I _S = 2 A		13		ns
Reverse Recovery Charge	Q_{RR}				12		nC
Charge Time	t _a				25		ns
9							

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

20

18

16

14

12

 $V_{DS} = \overline{10 \text{ V}}$

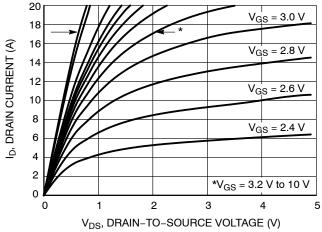
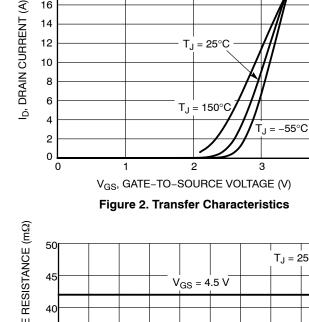


Figure 1. On-Region Characteristics



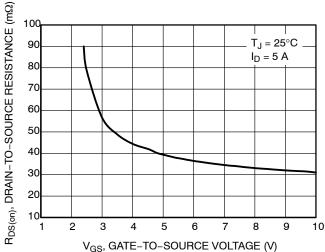
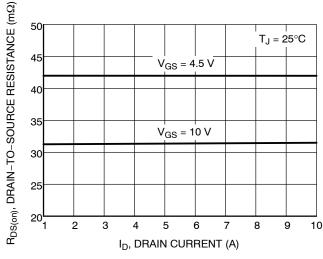


Figure 3. On-Resistance vs. Gate-to-Source Voltage



 $T_J = 25^{\circ}C$

Figure 4. On-Resistance vs. Drain Current and **Gate Voltage**

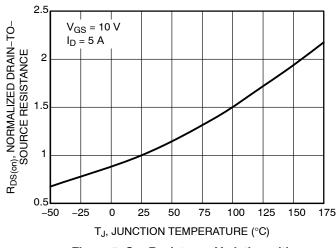


Figure 5. On-Resistance Variation with **Temperature**

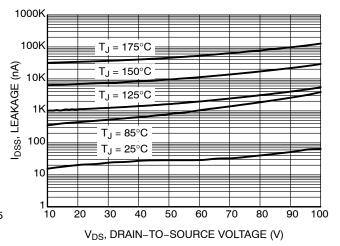


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

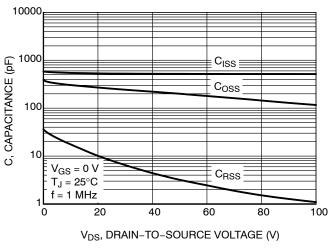


Figure 7. Capacitance Variation

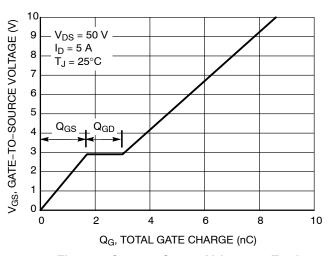


Figure 8. Gate-to-Source Voltage vs. Total Charge

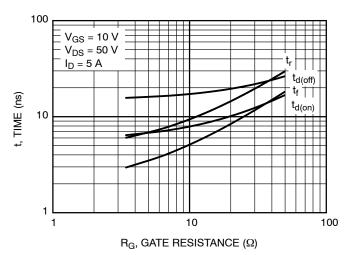


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

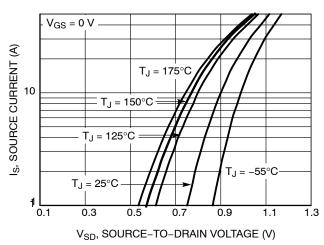


Figure 10. Diode Forward Voltage vs. Current

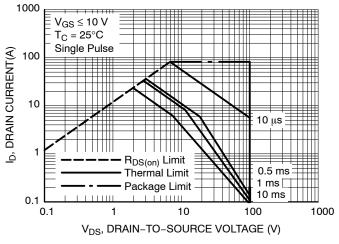


Figure 11. Maximum Rated Forward Biased Safe Operating Area

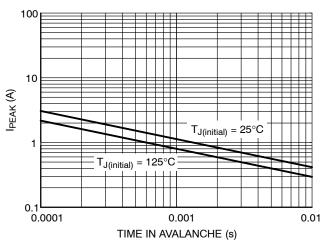


Figure 12. I_{PEAK} vs. Time in Avalanche

TYPICAL CHARACTERISTICS

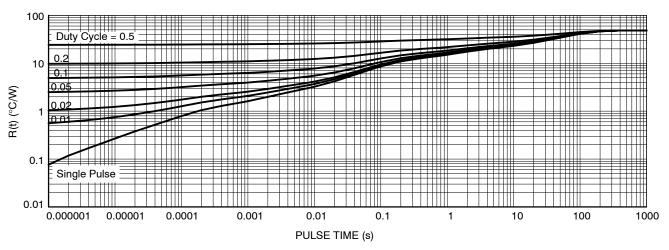


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVTFS040N10MCLTAG	40L1	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFWS040N10MCLTAG	40W1	WDFN8 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

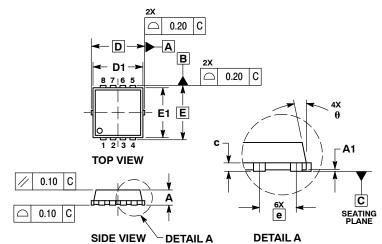
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

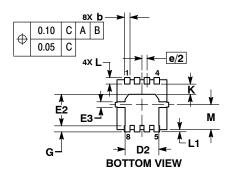
DATE 23 APR 2012



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	MI	LLIMETE	RS		INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		C	.130 BSC)
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
Е		3.30 BSC		C	.130 BSC)
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е		0.65 BSC	;	Ú	0.026 BS	2
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
M	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °

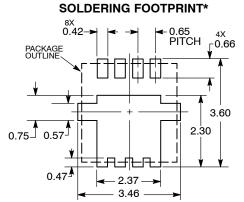


GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code Α = Assembly Location

= Year WW = Work Week = Pb-Free Package



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

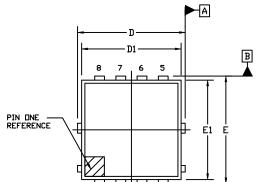
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DESCRIPTION:	WDFN8 3.3X3.3, 0.65P		PAGE 1 OF 1	

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^{*}This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF) CASE 515AN ISSUE O

DATE 25 AUG 2020



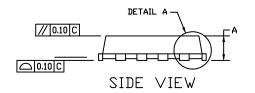
TOP VIEW

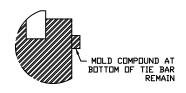


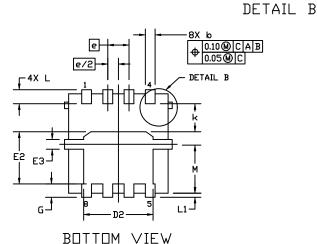
- 1. DIMENSIONING AND TOLERANCING PER.ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION D1 AND E1 D0 NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

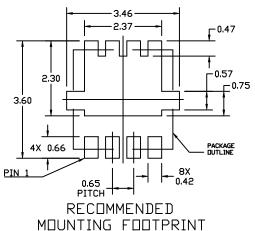
	ATED AREA
DETAIL A	C SEATING

	MILLIMETERS				
DIM	MIN.	NDM.	MAX.		
Α	0.70	0.75	0.80		
A1	0.00		0.05		
b	0.23	0.30	0.40		
С	0.15	0.20	0.25		
D	3.05	3.30	3.55		
D1	2.95	3.05	3.15		
D2	1.98	2.11	2.24		
Ε	3.05	3.30	3.55		
E1	2.95	3.05	3.15		
E2	1.47	1.60	1.73		
E3	0.23	0.30	0.40		
e		0.65 BSC			
G	0.30	0.41	0.51		
K	0.65	0.80	0.95		
L	0.30	0.43	0.59		
L1	0.06	0.13	0.20		
М	1.40	1.50	1.60		









* For additional information on our Pb-Free strategy and soldering details, please download the IIN Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*

XXXX AYWW• XXXX = Specific Device Code

A = Assembly Location

Y = Year

WW = Work Week

= Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

(Note: Microdot may be in either location)

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DESCRIPTION:	WDFNW8 3.3x3.3, 0.65P (F	WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF)		

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